

General Description

The 60N03 is N-channel MOSFET device that features a low on-state resistance and excellent switching characteristics, and designed for low voltage high current applications such as DC/DC converter with synchronous rectifier.

Features

- Simple Drive Requirement
- Low Gate Charge
- Fast Switching
- Ultra-Low RDS(on)
- Green Device Available

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D@T_C=25^\circ C$	Continuous Drain Current ¹	60	A
$I_D@T_C=100^\circ C$	Continuous Drain Current ¹	50	A
I_{DM}	Pulsed Drain Current ²	180	A
EAS	Single Pulse Avalanche Energy ³	55	mJ
I_{AS}	Avalanche Current	50	A
$P_D@T_C=25^\circ C$	Total Power Dissipation	55	W
T_{STG}	Storage Temperature Range	-55 to 175	$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 175	$^\circ C$

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹	---	52	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction -Case ¹	---	2.73	$^\circ C/W$

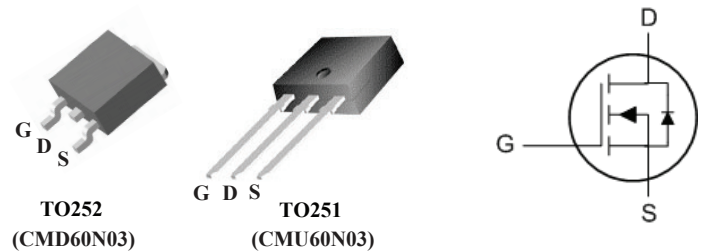
Product Summary

BVDSS	RDSON	ID
30V	7m Ω	60A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- DC/DC converter
- Motor drives

TO252 / TO251 Pin Configuration



TO252
(CMD60N03)

TO251
(CMU60N03)

N-Ch 30V Fast Switching MOSFETs

Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	30	---	---	V
ΔBV _{DSS} /ΔT _J	BVDSS Temperature Coefficient	Reference to 25 °C, I _D =250uA	---	0.012	---	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =20A	---	5	7	mΩ
		V _{GS} =4.5V, I _D =20A	---	9.5	13	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1	2	3	V
ΔV _{GS(th)}	V _{GS(th)} Temperature Coefficient		---	-6	---	mV/°C
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V, V _{GS} =0V, T _J =25°C	---	---	1	uA
		V _{DS} =24V, V _{GS} =0V, T _J =150°C	---	---	250	
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA
g _{fs}	Forward Transconductance	V _{DS} =5V, I _D =10A	---	45	---	S
R _g	Gate Resistance	V _{GS} =0.5V, f=1MHz	---	2.3	---	Ω
Q _g	Total Gate Charge	V _{DS} =15V I _D =20A V _{GS} =4.5V	---	15	---	nC
Q _{gs}	Gate-Source Charge		---	4.4	---	
Q _{gd}	Gate-Drain Charge		---	7.3	---	
T _{d(on)}	Turn-On Delay Time	V _{DD} =15V, V _{GS} =10V, R _{GS} =10Ω I _D =20A	---	10	---	ns
T _r	Rise Time		---	100	---	
T _{d(off)}	Turn-Off Delay Time		---	45	---	
T _f	Fall Time		---	38	---	
C _{iss}	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz	---	1150	---	pF
C _{oss}	Output Capacitance		---	250	---	
C _{rss}	Reverse Transfer Capacitance		---	150	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I _S	Continuous Source Current ¹	V _G =V _D =0V, Force Current	---	---	60	A
I _{SM}	Pulsed Source Current ²		---	---	180	A
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V, I _S =35A, T _J =25°C	---	---	1.25	V

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
- 2.The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
- 3.The EAS data shows Max. rating. The test condition is V_{DD}=27V, V_{GS}=10V, L=0.14mH, I_{AS}=28A